


<b>Search Notes</b> 	<b>Application/Control No.</b> 10024716	<b>Applicant(s)/Patent Under Reexamination</b> CHO, CHANG-HYUNG
	<b>Examiner</b> DAQUAN ZHAO	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner
386	52, 55, 95, 111-112	10/31/2008	dz

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT; USPGPUB; USOCR; EPO; JPO; IBM_TDB, DERWENT	10/31/2008	dz

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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